

Notice of References Cited	Application/Control No. 10/724,894	Applicant(s)/Patent Under Reexamination KONNO ET AL.	
	Examiner B. Chen	Art Unit 1762	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,977,136	12-1990	Fujiwara et al.	503/227
*	B	US-5,223,314	06-1993	Watanabe et al.	428/35.4
*	C	US-5,663,755	09-1997	Wada et al.	347/176
*	D	US-4,940,412	07-1990	Blumenthal, Rafael	434/267
*	E	US-6,795,209	09-2004	Patton et al.	358/1.18
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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